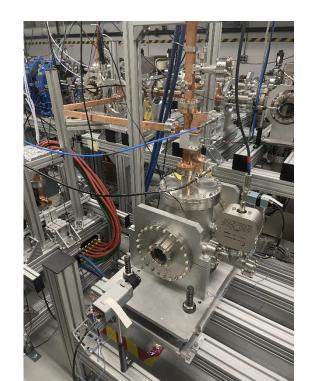


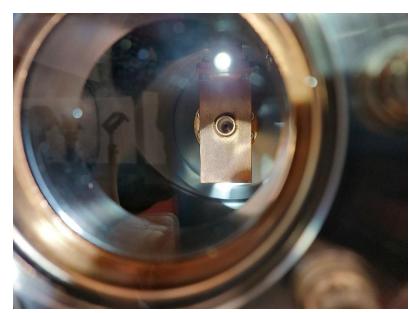


# High Power Test Results of X-Band Dielectric Disk Accelerating Structures



Ben Freemire for Euclid Beamlabs & Argonne Wakefield Accelerator

International Workshop on Breakdown Science and High Gradient Technology 19 May 2022



### **Motivation**

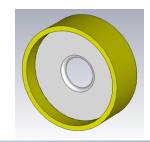
- Develop enabling technologies for TeV-scale linear colliders
- Support demonstration of 500 MeV electron beam energy gain using Two Beam Acceleration approach at Argonne Wakefield Accelerator
- Improve RF-to-beam efficiency
  - High shunt impedance and r/Q
  - High group velocity
- Short pulse high gradient acceleration



#### **Dielectric Disk Accelerators**

- Dielectric disk-loaded waveguides introduced in the 1940's-50's
- Modern ceramics with high dielectric constant and low loss provide opportunity to realize high shunt impedance structures
- Higher: group velocity, shunt impedance,
  Q
- Tuning easier than for DLAs
- Drawback: surface electric field much higher than DLAs, fabrication difficult

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26 GHz Parameter	DDA	DLA	Copper-Disk*
Aperture	3 mm	3 mm	3 mm
Outer Diameter	9.23 mm	4.99 mm	9.27 mm
Thickness	0.5 mm	1 mm (wall)	0.5 mm
Dielectric constant	50	10	N/A
Loss tangent	5e-4	1e-4	N/A
Group velocity	0.16c	0.11c	0.017c
Shunt Impedance	208 MΩ/m	50 MΩ/m	139 MΩ/m
Q	6400	2300	4300
Accel. gradient	363 MV/m	363 MV/m	N/A
Surface gradient	660 MV/m	363 MV/m	N/A

\*Constant impedance  $2\pi/3$  structure, not suitable for short RF pulse acceleration due to low group velocity

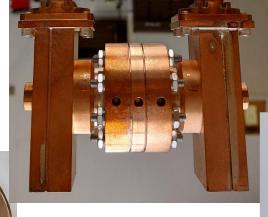


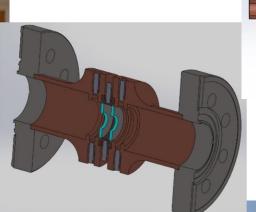
### **Euclid-AWA DDA Testing History**

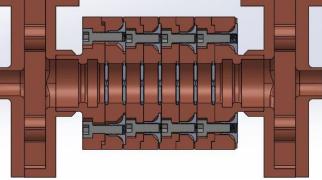
- Prototype I Brazed: Dec. 2019-Jan. 2020
- Prototype II Brazed: Failed during brazing
- Prototype III Clamped: Dec. 2021-Jan. 2022
- Prototype IV Brazed: upcoming 2022
- Multicell Clamped: upcoming 2022

S. Weatherly poster Thurs.





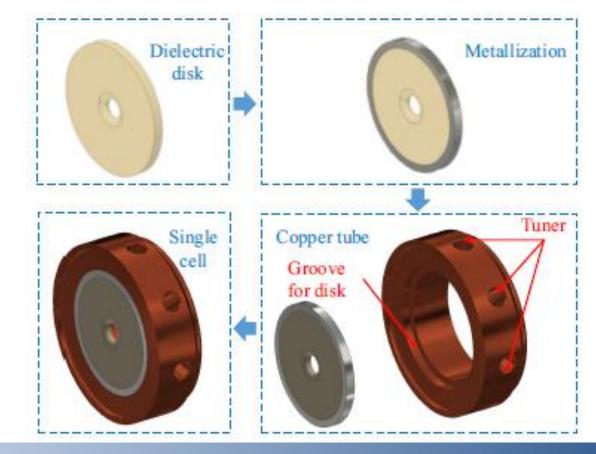






## Fabrication Challenges

- Most significant challenge for program
- Precision of dielectric properties
- Machining feasibility/tolerance
- Brazing vs. Clamping





#### Dielectric Material Characterization

- Prototype I & II:
- BaTiO<sub>x</sub> ceramic (D-50) from Skyworks (Trans-Tech)
- 10 coupons measured (4 GHz):
  - $-\epsilon_r = 50.14 \pm 0.35$
  - $-\tan \delta = 8.00e-5 \pm 0.32e-5$



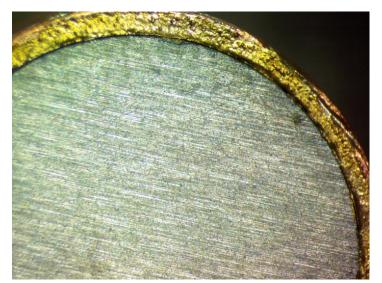
- Prototype III:
- Ca<sub>v</sub>Ti<sub>w</sub>La<sub>x</sub>Al<sub>v</sub>O<sub>z</sub> ceramic (D-47) from Keramika
- 3 coupons measured (3.8-7.4 GHz), extrapolated to 11.7 GHz
  - $\epsilon_{\rm r} = 47.7$
  - tan  $\delta = 3.44e-4$





## Investigation of Brazing Method

- High temperature InCuSil-ABA @835°C in vacuum furnace
- Hermetic seal successful; ceramic became lossy
- Post-braze bake in air reduced RF loss
- Oxygen escapes in vacuum at high temperature but can be reintroduced







	Temp.	Time	ε <sub>r</sub>	tan δ
Original	-	-	50.2	8.15e-5
Post-Braze	835	N/A	49.7	1.43e-2
Post-Bake 1	800	60 min.	49.3	7.17e-4
Post-Bake 2	800	60 min.	49.3	1.03e-4

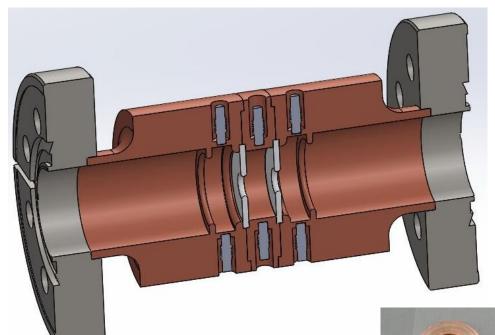


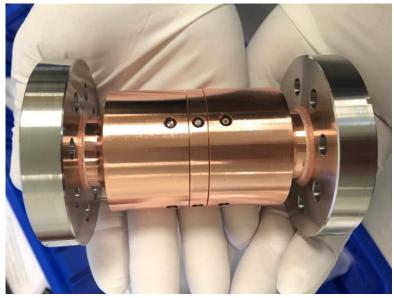
## Choice of Brazing Method

- Low temperature solder (Au-Sn, 350°C) with silver-metallized disks chosen for Prototype I
  - Metallization @ 850°C in air, preserved dielectric properties
- High temperature ABA (InCuSil, 850°C) with nude disks chosen for Prototype II
  - Leaked after first braze cycle
  - Second braze cycle improved leak
  - Third braze cycle cracked ceramic disks



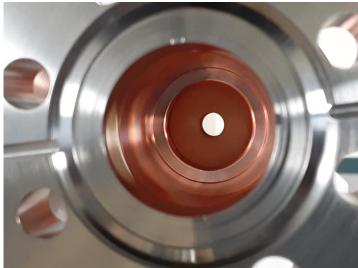
## **Brazed Prototype Fabrication**







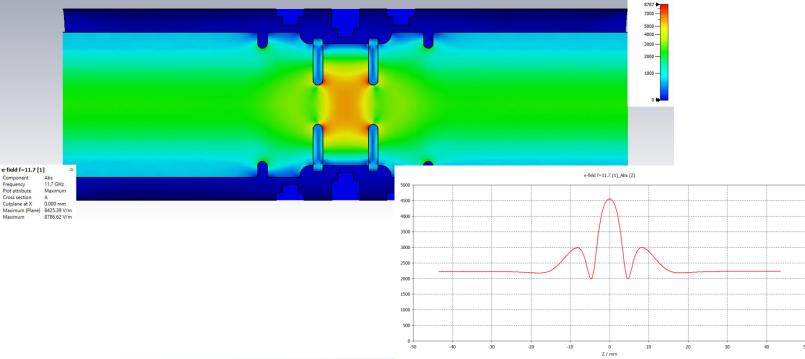


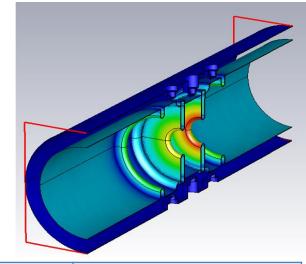




## Brazed Prototype RF Design

- 1 Dielectric cell (2 disks) + 2 matching cells
- f = 11.7 GHz, three sets of 4 tuners each allow
  ±3 MHz range





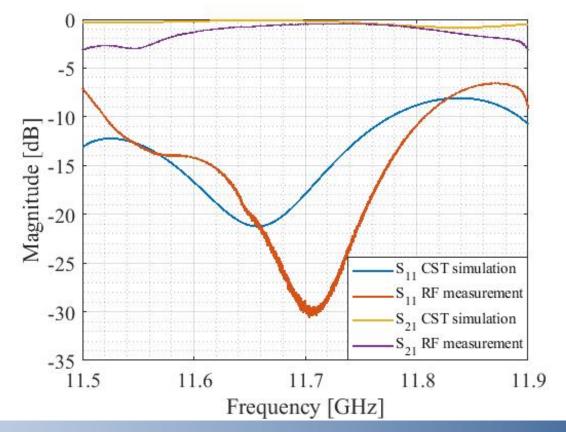
	Dielectric constant	50.1			
	Loss tangent	8e-5			
	Q	10,300			
	Shunt impedance	176 MΩ/m			
	Group velocity	0.345c			
-	Phase advance	2π/3			
	E <sub>acc</sub> (P <sub>in</sub> )	100 MV/m (280 MW)			
50	E <sub>max</sub> / E <sub>acc</sub>	1.84			



#### Brazed Prototype Bench Test

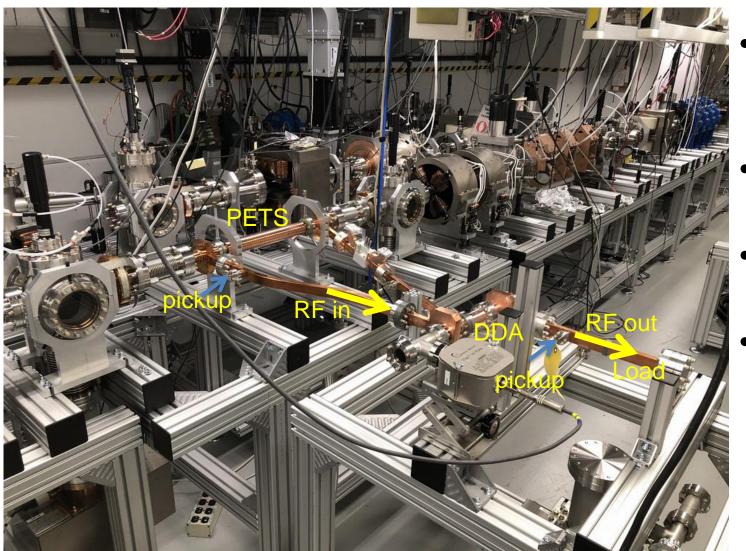
- Measured  $S_{21} = -0.50 \text{ dB \& } S_{11} \text{ 10 dB BW} = 290 \text{ MHz}$
- Differences attributable to discrepancies in machined dimensions/dielectric constant
  - Couplers included in simulation
- No tuning required







## High Power Test Setup

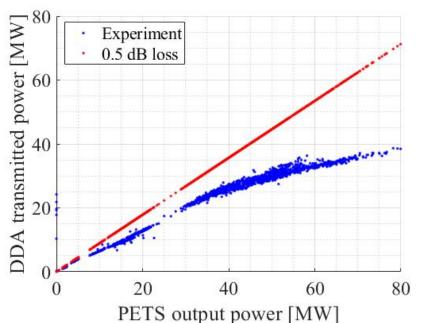


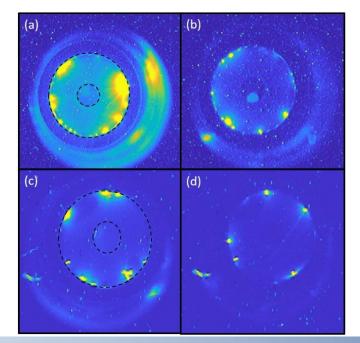
- Power provided by Power Extraction and Transport Structure (PETS)
- ICTs measure beam current for power generation
- Directional couplers at DDA input & output
- Instrumentation to look for multipacting/breakdown
  - Ion pump & vacuum gauge
  - Cameras on both ends of DDA

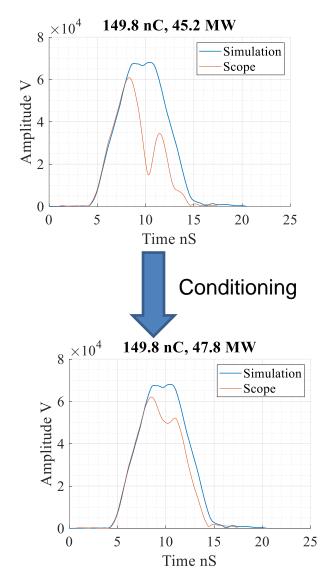


#### Brazed Prototype High Power Test Results

- Significant multipactor/breakdown activity observed
- Light emission from circumference of both ceramic disks
  - No light visible from irises
- Conditioning improved power transmission & light emission somewhat; never eliminated
- Run aborted at 80 MW input power









## Brazed Prototype Autopsy

Damage around ceramic circumference

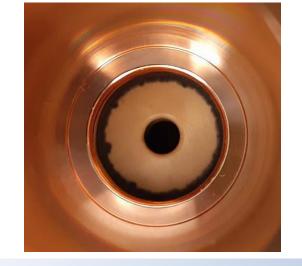
SEM & EDX results reveal pitting and presence of gold (braze alloy) and

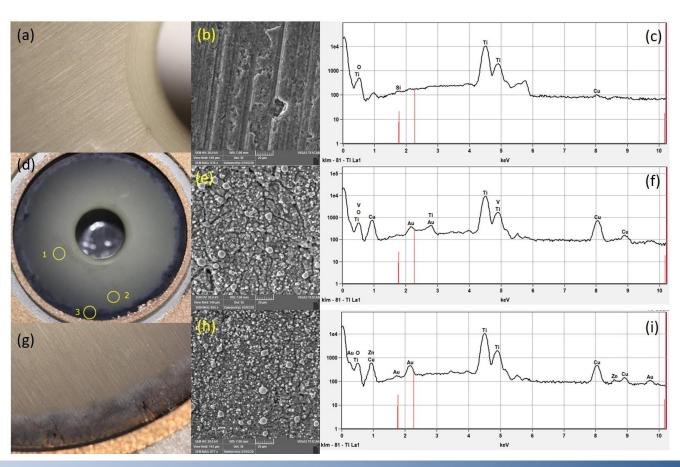
copper near outer radius of disks

 Iris & surrounding area free from damage or contamination

 Breakdown/ multipactor confined to triple junction

region

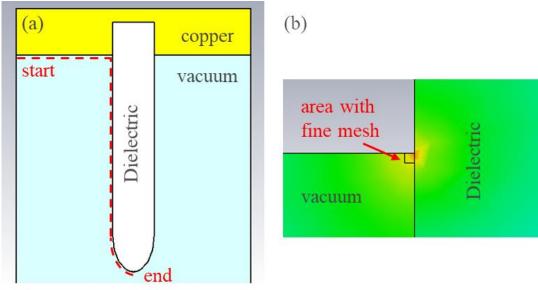


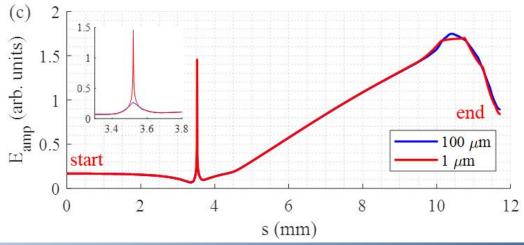




#### **Brazed Prototype Conclusions**

- Finer mesh revealed field enhancement at triple junction
- No evidence of problems stemming from iris or ceramic material
- Engineering challenge to overcome, not fundamental



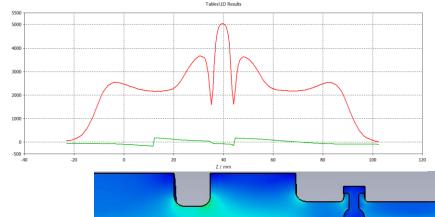


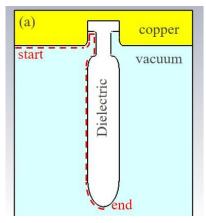


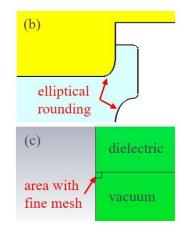
## Clamped Prototype RF Design

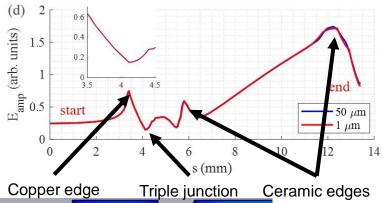
- Triple junction redesigned to minimize E-field
- Elliptic rounding added to copper and ceramic

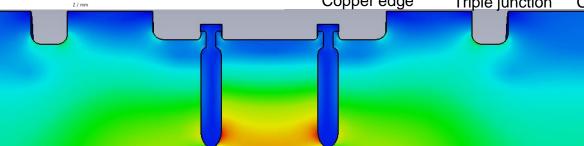
Dielectric constant	47.7
Loss tangent	3.4e-5
Q	8,500
Shunt impedance	174 MΩ/m
Group velocity	0.27c
Phase advance	2π/3
E <sub>acc</sub> (308 MW)	100 MV/m
E <sub>max</sub> / E <sub>acc</sub>	1.44









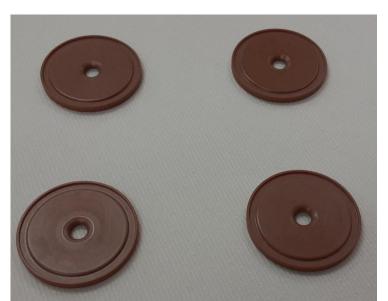


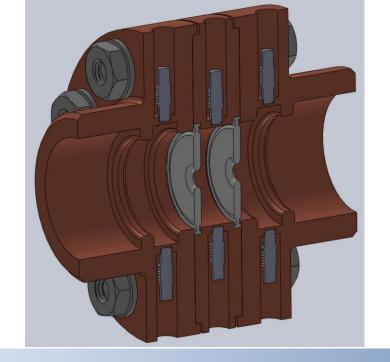


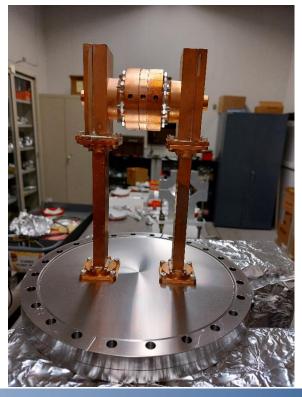
#### Clamped Prototype Fabrication

- Potential problem associated with braze alloy avoided
- No vacuum seal (tested in vacuum chamber)
- Outer edge of ceramic disks bite into annealed copper parts

Ceramic design more difficult to machine



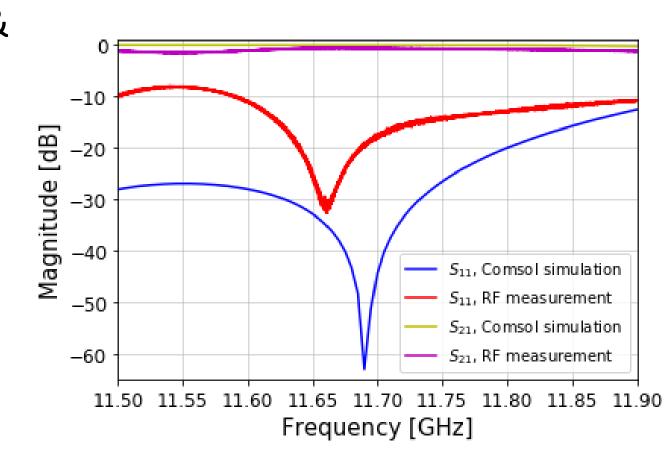






## Clamped Prototype Bench Test

- Measured  $S_{21} = -0.652 \text{ dB } \&$  $S_{11} \text{ 10 dB BW} = >640 \text{ MHz}$
- Differences attributable to discrepancies in machined dimensions/dielectric constant
  - Couplers included in simulation
- No tuning required

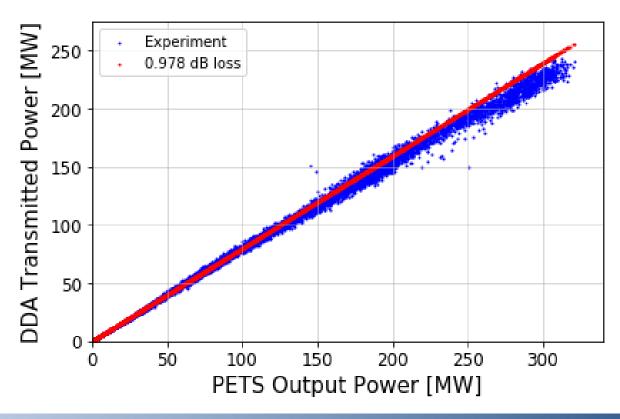




#### Clamped Prototype High Power Test Results

- No evidence (RF or light) of breakdown or multipacting
- Brief period of faint light from interior of structure at highest power conditioned away
- Transmitted power agrees very well with measured transmission loss from DDA+waveguide
- Limited by available input power!

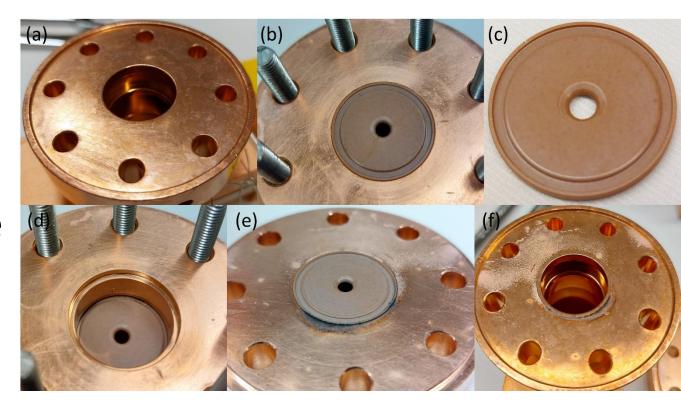
320.9 MW input power = 102.3 MV/m accelerating gradient





## Clamped Prototype Inspection

- No damage on ceramic or copper in RF volume
- Damage on copper surface and ceramic circumference in one cell due to RF leakage caused by inconsistent clamping force
  - May have been source of brief light during high power test





## Clamped Prototype Conclusions

- No multipactor or RF breakdown observed at high gradient
- Redesigned triple junction solved problem with brazed prototype
- 102.3 MV/m new accelerating gradient record for dielectric disk accelerator!
- Fundamental limit for DDAs still not reached



## <u>Outlook</u>

- Issues yet to be addressed:
  - Are these positive results confined to clamped DDAs?
    - Another brazed DDA in fabrication
  - What engineering challenges arise from "real" accelerating structures?
    - Multicell DDA already designed S. Weatherly's poster
  - How to properly stage DDAs to accelerate beam
    - Planned for 2023-2024



## Acknowledgements

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